

ECL programmable array logic

10H20EV8/10020EV8

DESCRIPTION

The 10H20EV8/10020EV8 is an ultra high-speed universal ECL PAL[®] device. Combining versatile output macrocells with a standard AND/OR single programmable array, this device is ideal in implementing a user's custom logic. The use of Philips Semiconductors state-of-the-art bipolar oxide isolation process enables the 10H20EV8/10020EV8 to achieve optimum speed in any design. The SNAP design software package from Philips Semiconductors simplifies design entry based upon Boolean or state equations.

The 10H20EV8/10020EV8 is a two-level logic element comprised of 11 fixed inputs, an input pin that can either be used as a clock or 12th input, 90 AND gates, and 8 Output Logic Macrocells. Each Output Macrocell can be individually configured as a dedicated input, dedicated output with polarity control, a bidirectional I/O, or as a registered output that has both output polarity control and feedback to the AND array. This gives the part the capability of having up to 20 inputs and eight outputs.

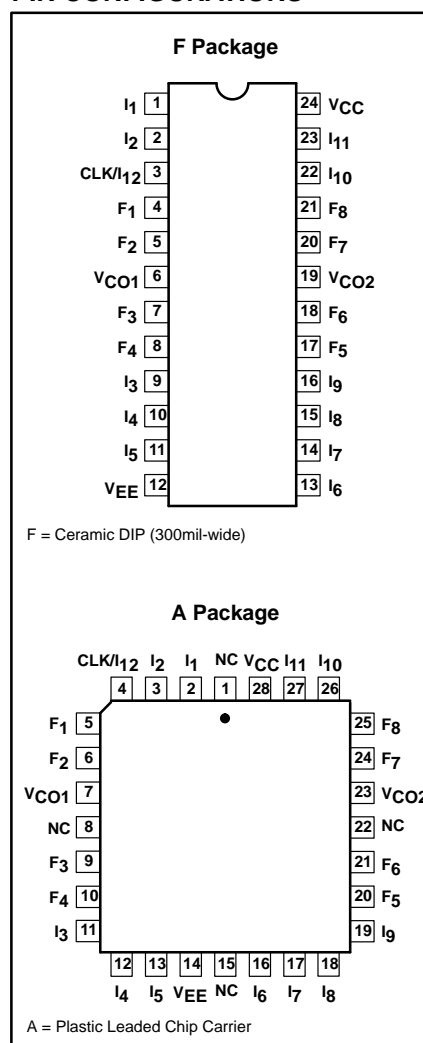
The 10H20EV8/10020EV8 has a variable number of product terms that can be OR'd per output. Four of the outputs have 12 AND terms available and the other four have 8 terms per output. This allows the designer the extra flexibility to implement those functions that he couldn't in a standard PAL device. Asynchronous Preset and Reset product terms are also included for system design ease. Each output has a separate output enable product term. Another feature added for the system designer is a power-up Reset on all registered outputs.

The 10H20EV8/10020EV8 also features the ability to Preload the registers to any desired state during testing. The Preload is not affected by the pattern within the device, so can be performed at any step in the testing sequence. This permits full logical verification even after the device has been patterned.

FEATURES

- Ultra high speed ECL device
 - $t_{PD} = 4.5\text{ns}$ (max)
 - $t_{IS} = 2.6\text{ns}$ (max)
 - $t_{CKO} = 2.3\text{ns}$ (max)
 - $f_{MAX} = 208\text{MHz}$
- Universal ECL Programmable Array Logic
 - 8 user programmable output macrocells
 - Up to 20 inputs and 8 outputs
 - Individual user programmable output polarity
- Variable product term distribution allows increased design capability
- Asynchronous Preset and Reset capability
- 10KH and 100K options
- Power-up Reset and Preload function to enhance state machine design and testing
- Design support provided via SNAP and other CAD tools
- Security fuse for preventing design duplication
- Available in 24-Pin 300mil-wide DIP and 28-Pin PLCC.

PIN CONFIGURATIONS



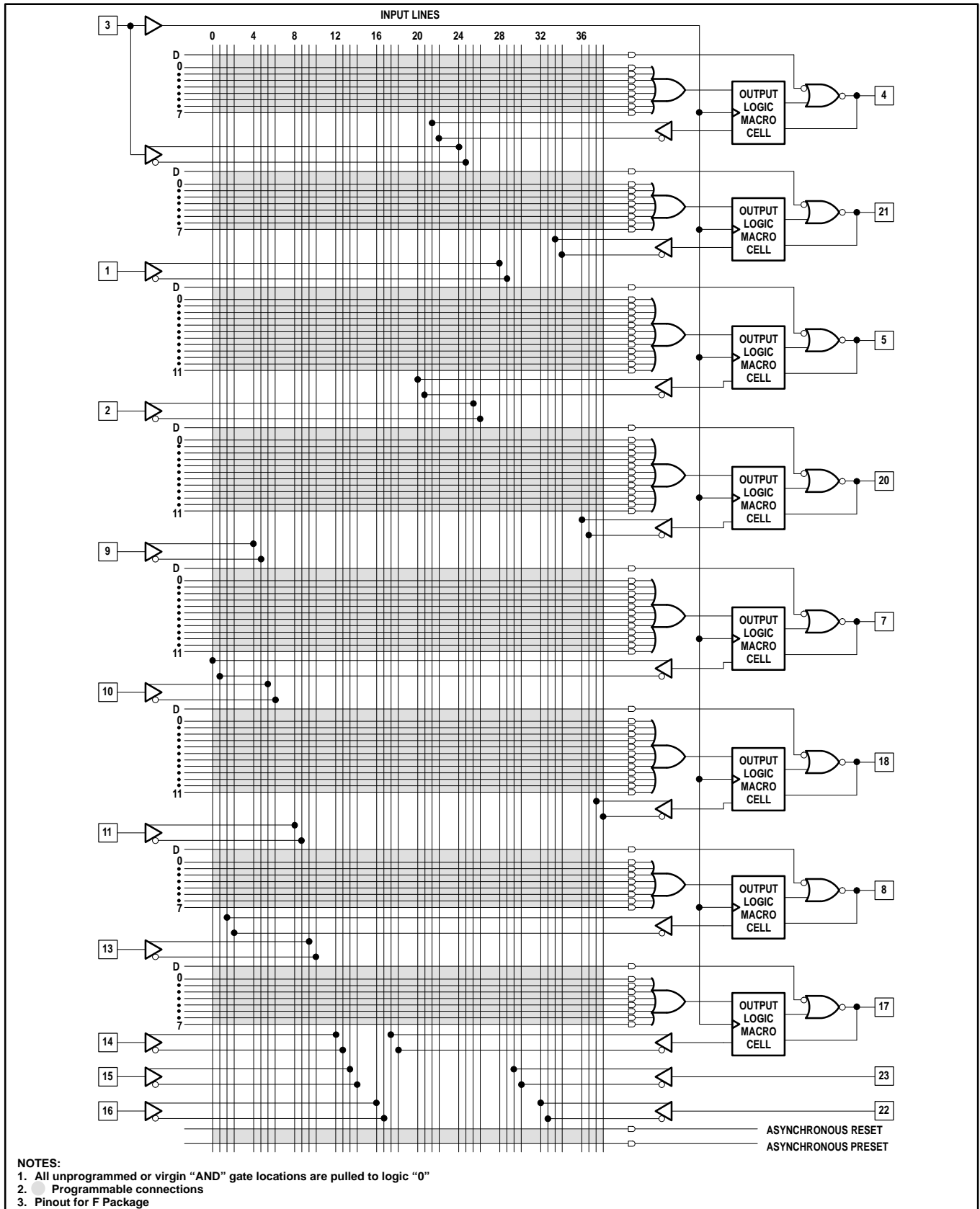
ORDERING INFORMATION

DESCRIPTION	ORDER CODE	DRAWING NUMBER
24-Pin Ceramic Dual In-Line (300mil-wide)	10H20EV8-4F 10020EV8-4F	0586B
28-Pin Plastic Leaded Chip Carrier	10H20EV8-4A 10020EV8-4A	0401F

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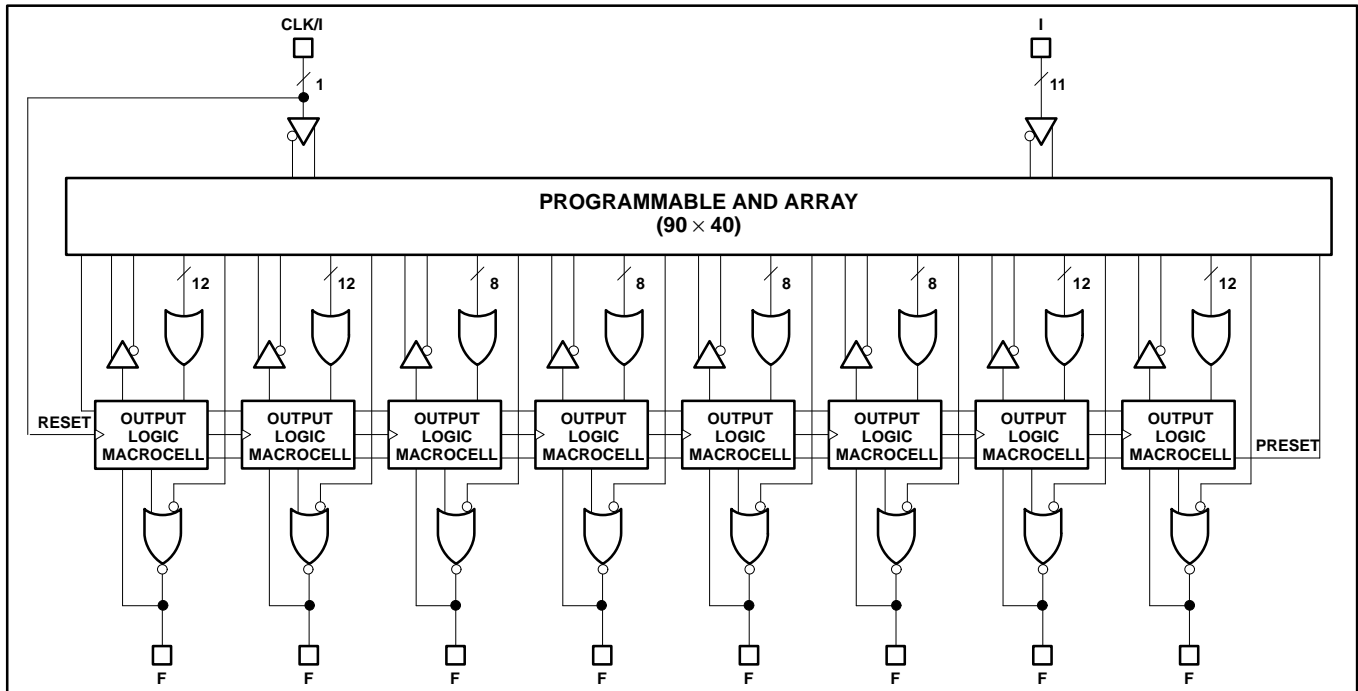
LOGIC DIAGRAM



ECL programmable array logic

10H20EV8/10020EV8

FUNCTIONAL DIAGRAM



FUNCTIONAL DESCRIPTION

The 10H20EV8/10020EV8 is an ultra high-speed universal ECL PAL-type device. Combining versatile Output Macrocells with a standard AND/OR single programmable array, this device is ideal in implementing a user's custom logic.

As can be seen in the Logic Diagram, the device is a two-level logic element with a programmable AND array. The 20EV8 can have up to 20 inputs and 8 outputs. Each output has a versatile Macrocell whereby the output can either be configured as a dedicated input, a dedicated combinatorial output with polarity control, a bidirectional I/O, or as a registered output that has both output polarity control and feedback into the AND array.

The device also features 90 product terms. Two of the product terms can be used for a global asynchronous preset and/or reset. Eight of the product terms can be used for individual output enable control of each Macrocell. The other 80 product terms are distributed among the outputs. Four of the outputs have eight product terms, while the other four have 12. This arrangement allows the utmost in flexibility when implementing user patterns.

Output Logic Macrocell

The 10H20EV8/10020EV8 incorporates an extremely versatile Output Logic Macrocell that allows the user complete flexibility when configuring outputs.

As seen in Figure 1, the 10H20EV8/10020EV8 Output Logic Macrocell consists of an edge-triggered D-type flip-flop, an output select MUX, and a feedback select MUX. Fuses S_0 and S_1 allow the user to select between the various cells. S_1 controls whether the output will be either registered with internal feedback or combinatorial I/O. S_0 controls the polarity of the output (Active-HIGH or Active-LOW). This allows the user to achieve the following configurations: Registered Active-HIGH output, Registered Active-LOW output, Combinatorial Active-HIGH output, and Combinatorial Active-LOW output. With the output enable product term, this list can be extended by adding the configurations of a Combinatorial I/O with Polarity or another input.

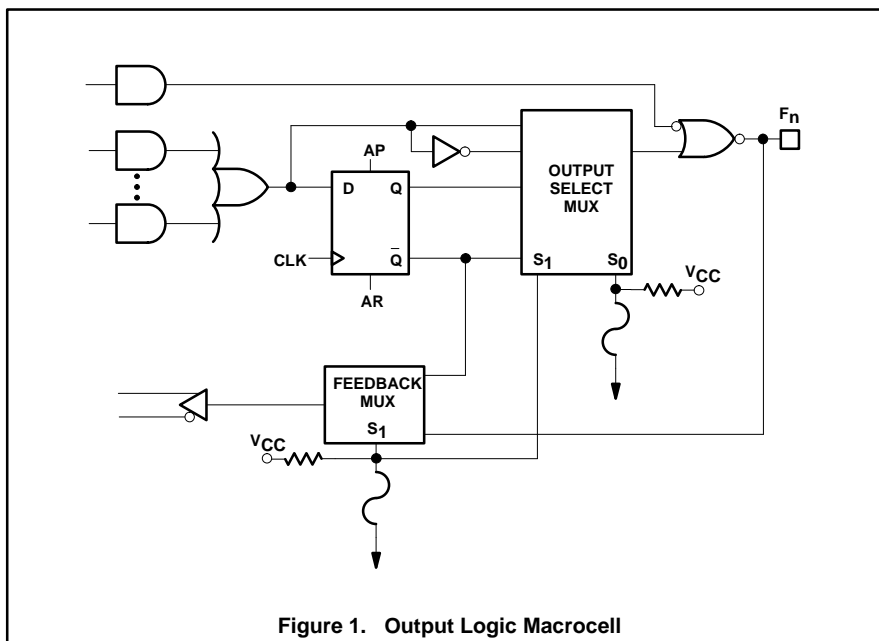


Figure 1. Output Logic Macrocell

ECL programmable array logic

10H20EV8/10020EV8

ABSOLUTE MAXIMUM RATINGS¹

SYMBOL	PARAMETER	RATING	UNIT	
V_{EE}	Supply voltage	-8.0	V	
V_{IN}	Input voltage (V_{IN} should never be more negative than V_{EE})	0 to V_{EE}	V	
I_O	Output source current	-50	mA	
T_S	Operating Temperature range	-55 to +150	°C	
T_J	Storage Temperature range	Ceramic Package	+165	°C
		Plastic Package	+150	°C

NOTE:

1. Stresses above those listed may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.

DC OPERATING CONDITIONS 10H20EV8

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN	NOM	MAX	
V_{CC}, V_{CO1}, V_{CO2}	Circuit ground		0	0	0	V
V_{EE}	Supply voltage (negative)			-5.2		V
V_{IH}	High level input voltage	$T_{amb} = 0^\circ\text{C}$	-1170		-840	mV
		$T_{amb} = +25^\circ\text{C}$	-1130		-810	mV
		$T_{amb} = +75^\circ\text{C}$	-1070		-735	mV
V_{IL}	Low level input voltage	$T_{amb} = 0^\circ\text{C}$	-1950		-1480	mV
		$T_{amb} = +25^\circ\text{C}$	-1950		-1480	mV
		$T_{amb} = +75^\circ\text{C}$	-1980		-1450	mV
T_{amb}	Operating ambient temperature range		0	+25	+75	°C

NOTE:

When operating at other than the specified V_{EE} voltage (-5.2V), the DC and AC Electrical Characteristics will vary slightly from specified values.

DC OPERATING CONDITIONS 10020EV8

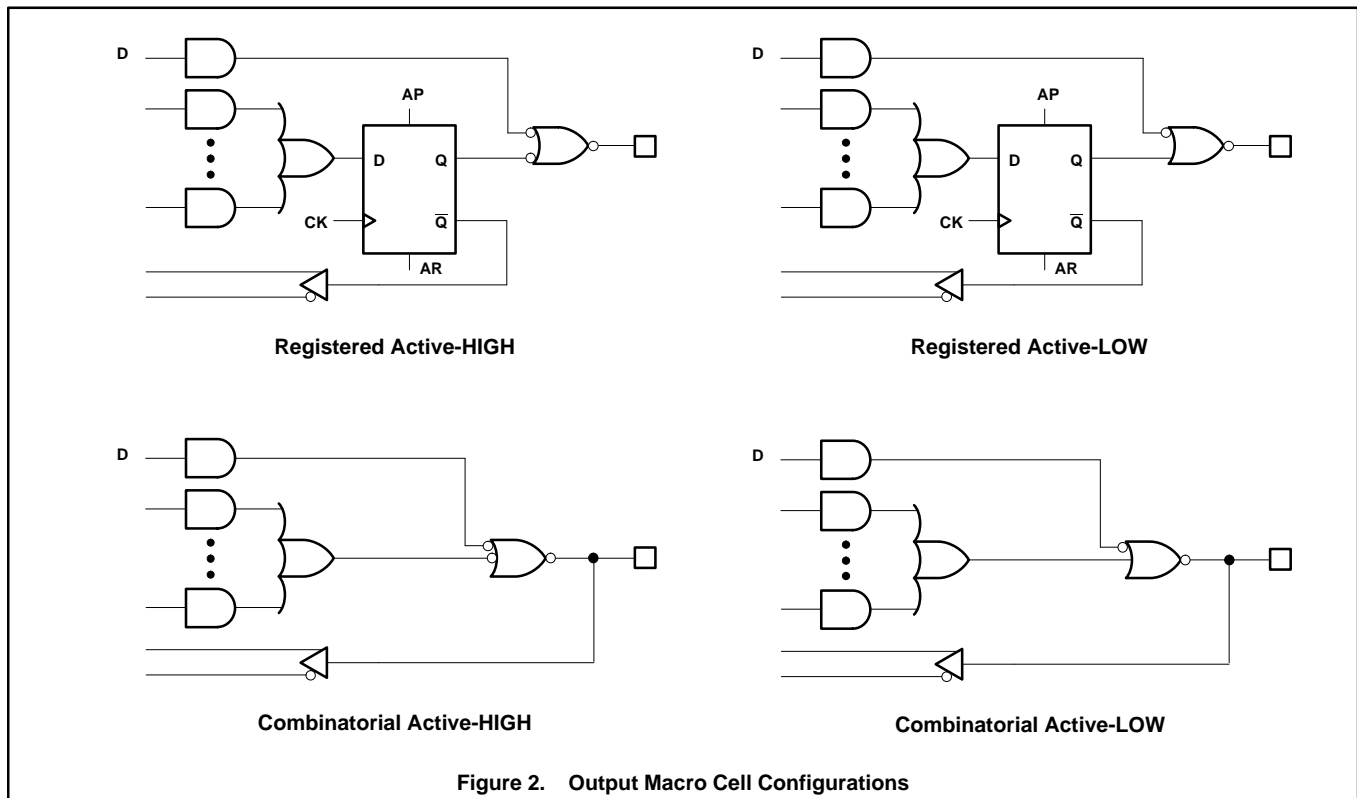
SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN	NOM	MAX	
V_{CC}, V_{CO1}, V_{CO2}	Circuit ground		0	0	0	V
V_{EE}	Supply voltage		-4.8	-4.5	-4.2	V
V_{EE}	Supply voltage when operating with the 10K or 10KH ECL family		-5.7			V
V_{IH}	High level input voltage	$V_{EE} = -4.2\text{V}$	-1150		-880	mV
		$V_{EE} = -4.5\text{V}$	-1165			
		$V_{EE} = -4.8\text{V}$	-1165			
V_{IL}	Low level input voltage	$V_{EE} = -4.2\text{V}$	-1810		-1475	mV
		$V_{EE} = -4.5\text{V}$			-1475	mV
		$V_{EE} = -4.8\text{V}$			-1490	mV
T_{amb}	Operating ambient temperature range		0	+25	+85	°C

NOTE:

When operating at other than the specified V_{EE} voltages (-4.2V, -4.5V, -4.8V), the DC and AC Electrical Characteristics will vary slightly from their specified values.

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OUTPUT MACRO CELL CONFIGURATION

Shown in Figure 2 are the four possible configurations of the output macrocell using fuses S_0 and S_1 . As seen, the output can either be registered Active-HIGH/LOW with feedback or combinatorial Active-HIGH/LOW with feedback. If the registered mode is chosen, the feedback from the \bar{Q} output to the AND array enables one to make state machines or shift registers without having to tie the output to one of the inputs. If a combinatorial output is chosen, the feedback gate is enabled from the pin and allows one to create permanent outputs, permanent inputs, or I/O pins through the use of the output enable (D) product term.

OUTPUT ENABLE

Each output on the 10H20EV8/10020EV8 has its own individual product term for output enable. The use of the D product term (direction control) allows the user three possible configurations of the outputs. They are: always enabled, always disabled, and

controlled by a programmed pattern. A HIGH on the D term enables the output, while a LOW performs the disable function. Output enable control can be achieved by programming a pattern on the D term.

The output enable control can also be used to expand a designer's possibilities once a combinatorial output has been chosen. If the D term is always HIGH, the pin becomes a permanent Active-HIGH/LOW output. If the D term is always LOW (all fuses left intact), the pin now becomes an extra input.

PRESET AND RESET

The 10H20EV8/10020EV8 also includes a separate product term for asynchronous Preset and asynchronous Reset. These lines are common for all registers and are asserted when the specific product term goes HIGH. Being asynchronous, they are independent of the clock. It should be noted that the actual state of the output is dependent on how the polarity of the particular output has been chosen. If the outputs are a mix of

Active-HIGH and Active-LOW, a Preset signal will force the Active-HIGH outputs HIGH while the Active-LOW outputs would go LOW, even though the Q output of all flip-flops would go HIGH. A Reset signal would force the opposite conditions.

PRELOAD

To simplify testing, the 10H20EV8/10020EV8 has also included PRELOAD circuitry. This allows a user to load any particular data desired into the registers regardless of the programmed pattern. This means that the PRELOAD can be done on a blank part and after that same part has been programmed to facilitate any post-fuse testing desired.

It can also be used by a designer to help debug a circuit. This could be important if a state machine was implemented in the 10H20EV8/10020EV8. The PRELOAD would allow the entry of any state in the sequence desired and start clocking from that particular point. Any or all transitions could be verified.

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DC ELECTRICAL CHARACTERISTICS 10H20EV8
 $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +75^{\circ}\text{C}$, $V_{\text{EE}} = -5.2\text{V} \pm 5\%$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

SYMBOL	PARAMETER ¹	TEST CONDITIONS ²	T _{amb}	LIMITS ⁴		UNITS
				MIN	MAX	
V _{OH}	High level output voltage	V _{IN} = V _{IH} MIN or V _{IL} MAX	0°C +25°C +75°C	-1020 -980 -920	-840 -810 -735	mV
V _{OL}	Low level output voltage	V _{IN} = V _{IH} MIN or V _{IL} MAX	0°C +25°C +75°C	-1950 -1950 -1950	-1630 -1630 -1600	mV
I _{IH}	High level input current	V _{IN} = V _{IH} MAX	0°C +75°C		220	μA
I _{IL}	Low level input current	V _{IN} = V _{IL} MIN Except I/O Pins	0°C +75°C	0.3		μA
-I _{EE}	Supply current	V _{EE} = MAX All inputs = V _{IH} MAX	0°C to +75°C		250	mA

DC ELECTRICAL CHARACTERISTICS 10020EV8
 $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +85^{\circ}\text{C}$, $-4.8\text{V} \leq V_{\text{EE}} \leq -4.2\text{V}$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

SYMBOL	PARAMETER ¹	TEST CONDITIONS ²	LIMITS ⁴			UNITS	
			MIN	TYP	MAX		
V _{OH}	High level output voltage	V _{IN} = V _{IH} MAX or V _{IL} MIN	V _{EE} = -4.2V	-1020		-870	mV
			V _{EE} = -4.5V	-1025	-955	-880	mV
			V _{EE} = -4.8V	-1035		-880	mV
V _{OHT}	High level output threshold voltage	Outputs Loaded with 50Ω to -2.0V ± 0.010V	Apply V _{IHMIN} or V _{ILMAX} to one input at a time, other inuts at V _{IHMAX} or V _{ILMIN} .	V _{EE} = -4.2V	-1030		mV
			V _{EE} = -4.5V	-1035		mV	
			V _{EE} = -4.8V	-1045		mV	
V _{OLT}	Low level output threshold voltage	Apply V _{IHMIN} or V _{ILMAX} to one input at a time, other inuts at V _{IHMAX} or V _{ILMIN} .	V _{EE} = -4.2V			-1595	mV
			V _{EE} = -4.5V			-1610	mV
			V _{EE} = -4.8V			-1610	mV
V _{OL}	Low level output voltage	Inuts at V _{IHMAX} or V _{ILMIN} .	V _{EE} = -4.2V	-1810		-1605	mV
			V _{EE} = -4.5V	-1810	-1705	-1620	mV
			V _{EE} = -4.8V	-1830		-1620	mV
I _{IH}	High level input current	One input under test at V _{IHMAX} . Other inputs at V _{ILMIN} .			220	μA	
I _{IL}	Low level input current	One input under test at V _{ILMIN} . Other inputs at V _{IHMAX} .	0.5			μA	
-I _{EE}	V _{EE} supply current	All inputs at V _{IHMAX} .			230	mA	

NOTES:

- All voltage measurements are referenced to the ground terminal.
- Each ECL 10KH/100K series device has been designed to meet the DC specification after thermal equilibrium has been established. Thermal equilibrium is established by applying power for at least 2 minutes, while maintaining transverse airflow of 2.5 meters/sec (500 linear feet/min.) over the device, mounted either in a test socket or on a printed circuit board. Test voltage values are given in the DC operating conditions table. Conditions for testing shown in the tables are not necessarily worst case. For worst case testing guidelines, refer to DC Testing, Chapter 1, Section 3, of the *Philips Semiconductors 10/100K ECL Data Handbook*.
- Terminals not specifically referenced can be left electrically open. Open inputs assume a logic LOW state. Any unused pins can be terminated to -2V. If tied to V_{EE}, it must be through a resistor > 10K. It is recommended that pins that have been programmed as RESET, PRESET, or CLOCK inputs not be left open due to the possibility of false triggering from internally and externally generated switching transients.
- The specified limits represent the worst case values for the parameter. Since these worst case values normally occur at the supply voltage and temperature extremes, additional noise immunity can be achieved by decreasing the allowable operating condition ranges.

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AC ELECTRICAL CHARACTERISTICS (for Ceramic Dual In-Line Package)

10H20EV8: $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +75^{\circ}\text{C}$, $V_{\text{EE}} = -5.2\text{V} \pm 5\%$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

10020EV8: $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +85^{\circ}\text{C}$, $-4.8\text{V} \leq V_{\text{EE}} \leq -4.2\text{V}$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

SYMBOL	PARAMETER	FROM	TO	LIMITS ¹									UNIT
				0°C			+25°C			+75°C/+85°C			
				MIN ²	TYP ³	MAX ₂	MIN ²	TYP ³	MAX ₂	MIN ²	TYP ³	MAX ₂	
Pulse Width													
t _{CKH}	Clock High	CLK +	CLK -	2.0	0.6		2.0	0.6		2.0	0.6		ns
t _{CKL}	Clock Low	CLK -	CLK +	2.0	0.9		2.0	0.9		2.0	0.9		ns
t _{CKP}	Clock Period	CLK +	CLK +	4.0			4.0			4.0			ns
t _{PRH}	Preset/Reset Pulse	(I, I/O) ±	(I, I/O) ±	4.5	—		4.5	—		4.5	—		ns
Setup and Hold Time													
t _{IS}	Input	(I, I/O) ±	CLK +	2.6	1.0		2.6	1.1		2.7	1.4		ns
t _{IH}	Input	CLK +	(I, I/O) ±	0.1	< 0		0.1	< 0		0.1	< 0		ns
t _{PRS}	Clock Resume after Preset/Reset	(I, I/O) ±	CLK +	4.6	1.0		4.6	0.9		4.6	0.8		ns
Propagation Delay													
t _{PD}	Input	(I, I/O) ±	I/O ±		2.85	4.7		2.95	4.7		3.35	4.7	ns
t _{CKO}	Clock	CLK +	I/O ±		1.65	2.4		1.7	2.4		2.0	2.5	ns
t _{OE}	Output Enable	(I, I/O) ±	I/O		2.0	4.2		2.1	4.2		2.2	4.2	ns
t _{OD}	Output Disable	(I, I/O) ±	I/O		2.0	4.2		2.1	4.2		2.2	4.2	ns
t _{PRO}	Preset/Reset	(I, I/O) ±	I/O ±		2.8	4.7		3.0	4.7		3.5	4.7	ns
t _{PPR}	Power-on Reset	V _{EE}	I/O		—	10		—	10		—	10	ns
f _{MAX}					212	377		212	357		204	294	MHz

NOTES:

1. Refer to AC Test Circuit and Voltage Waveforms diagrams.
2. Maximum loading conditions: 89 fuses intact per row.
3. Typical loading conditions: 15 fuses intact per row. (All "inactive" fuses, except those necessary for correct functionality, are removed.)

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AC ELECTRICAL CHARACTERISTICS (for Plastic Leaded Chip Carrier)

10H20EV8: $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +75^{\circ}\text{C}$, $V_{\text{EE}} = -5.2\text{V} \pm 5\%$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

10020EV8: $0^{\circ}\text{C} \leq T_{\text{amb}} \leq +85^{\circ}\text{C}$, $-4.8\text{V} \leq V_{\text{EE}} \leq -4.2\text{V}$, $V_{\text{CC}} = V_{\text{CO1}} = V_{\text{CO2}} = \text{GND}$

SYMBOL	PARAMETER	FROM	TO	LIMITS ¹									UNIT
				0°C			+25°C			+75°C/+85°C			
				MIN	TYP ³	MAX ₂	MIN	TYP ³	MAX ₂	MIN	TYP ³	MAX ₂	
Pulse Width													
t _{CKH}	Clock High	CLK +	CLK -	2.0	0.6		2.0	0.6		2.0	0.6		ns
t _{CKL}	Clock Low	CLK -	CLK +	2.0	0.9		2.0	0.9		2.0	0.9		ns
t _{CKP}	Clock Period	CLK +	CLK +	4.0			4.0			4.0			ns
t _{PRH}	Preset/Reset Pulse	(I, I/O) ±	(I, I/O) ±	4.5	—		4.5	—		4.5	—		ns
Setup and Hold Time													
t _{IS}	Input	(I, I/O) ±	CLK +	2.5	1.0		2.5	1.1		2.6	1.4		ns
t _{IH}	Input	CLK +	(I, I/O) ±	0	< 0		0	< 0		0	< 0		ns
t _{PRS}	Clock Resume after Preset/Reset	(I, I/O) ±	CLK +	4.5	1.0		4.5	0.9		4.5	0.8		ns
Propagation Delay													
t _{PD}	Input	(I, I/O) ±	I/O ±		2.85	4.5		2.95	4.5		3.35	4.5	ns
t _{CKO}	Clock	CLK +	I/O ±		1.65	2.2		1.7	2.2		2.0	2.3	ns
t _{OE}	Output Enable	(I, I/O) ±	I/O		2.0	4.0		2.1	4.0		2.2	4.0	ns
t _{OD}	Output Disable	(I, I/O) ±	I/O		2.0	4.0		2.1	4.0		2.2	4.0	ns
t _{PRO}	Preset/Reset	(I, I/O) ±	I/O ±		2.8	4.5		3.0	4.5		3.5	4.5	ns
t _{PPR}	Power-on Reset	V _{EE}	I/O		—	10		—	10		—	10	ns
f _{MAX}					212	377		212	357		204	294	MHz

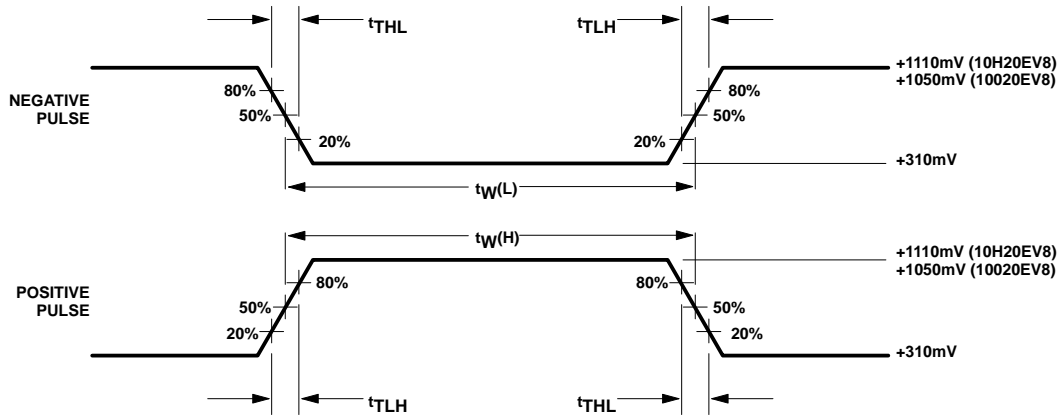
NOTES:

1. Refer to AC Test Circuit and Voltage Waveforms diagrams.
2. Maximum loading conditions: 89 fuses intact per row.
3. Typical loading conditions: 15 fuses intact per row. (All "inactive" fuses, except those necessary for correct functionality, are removed.)

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VOLTAGE WAVEFORMS



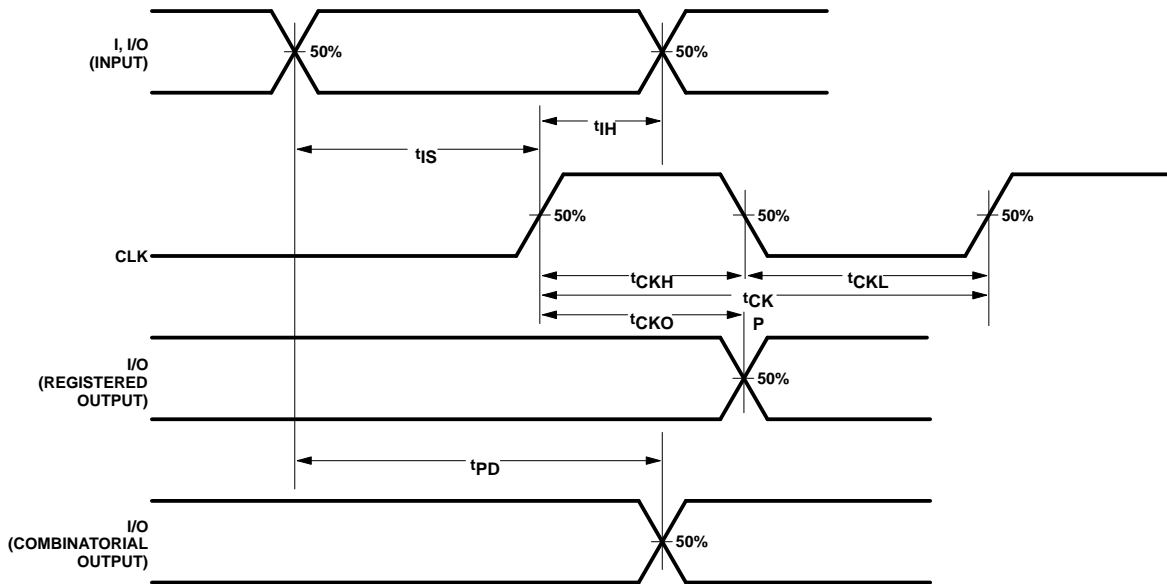
INPUT PULSE REQUIREMENTS					
$V_{CC} = V_{CO1} = V_{CO2} = +2.0V \pm 0.010V, V_{EE} = -3.2V \pm 0.010V, V_T = GND (0V)$					
FAMILY	AMPLITUDE	REP RATE	PULSE WIDTH	t_{TLH}	t_{THL}
10KH ECL	800mV _{p-p}	1MHz	500ns	$1.3 \pm 0.2ns$	$1.3 \pm 0.2ns$
INPUT PULSE REQUIREMENTS					
$V_{CC} = V_{CO1} = V_{CO2} = +2.0V \pm 0.010V, V_{EE} = -2.5V \pm 0.010V, V_T = GND (0V)$					
FAMILY	AMPLITUDE	REP RATE	PULSE WIDTH	t_{TLH}	t_{THL}
100K ECL	740mV _{p-p}	1MHz	500ns	$0.7 \pm 0.1ns$	$0.7 \pm 0.1ns$

Input Pulse Definition

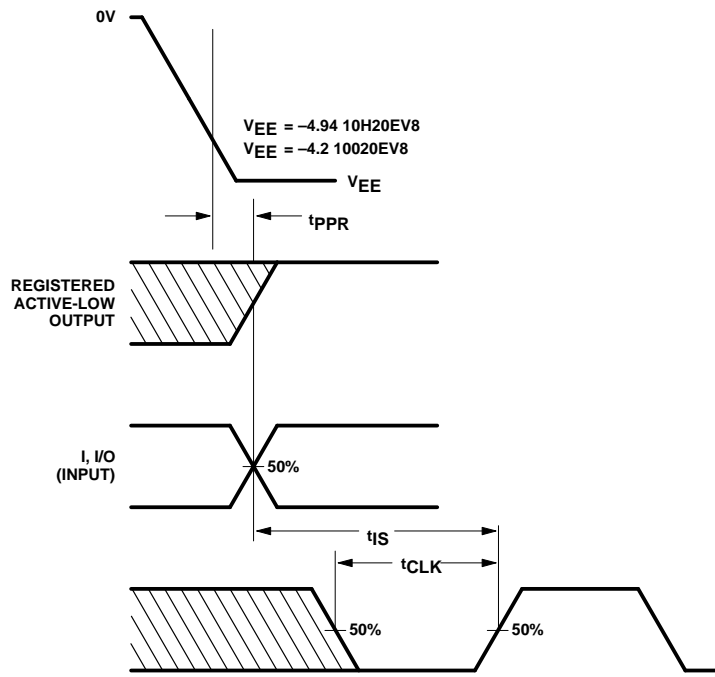
ECL programmable array logic

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TIMING DIAGRAMS



Flip-Flop and Gate Outputs

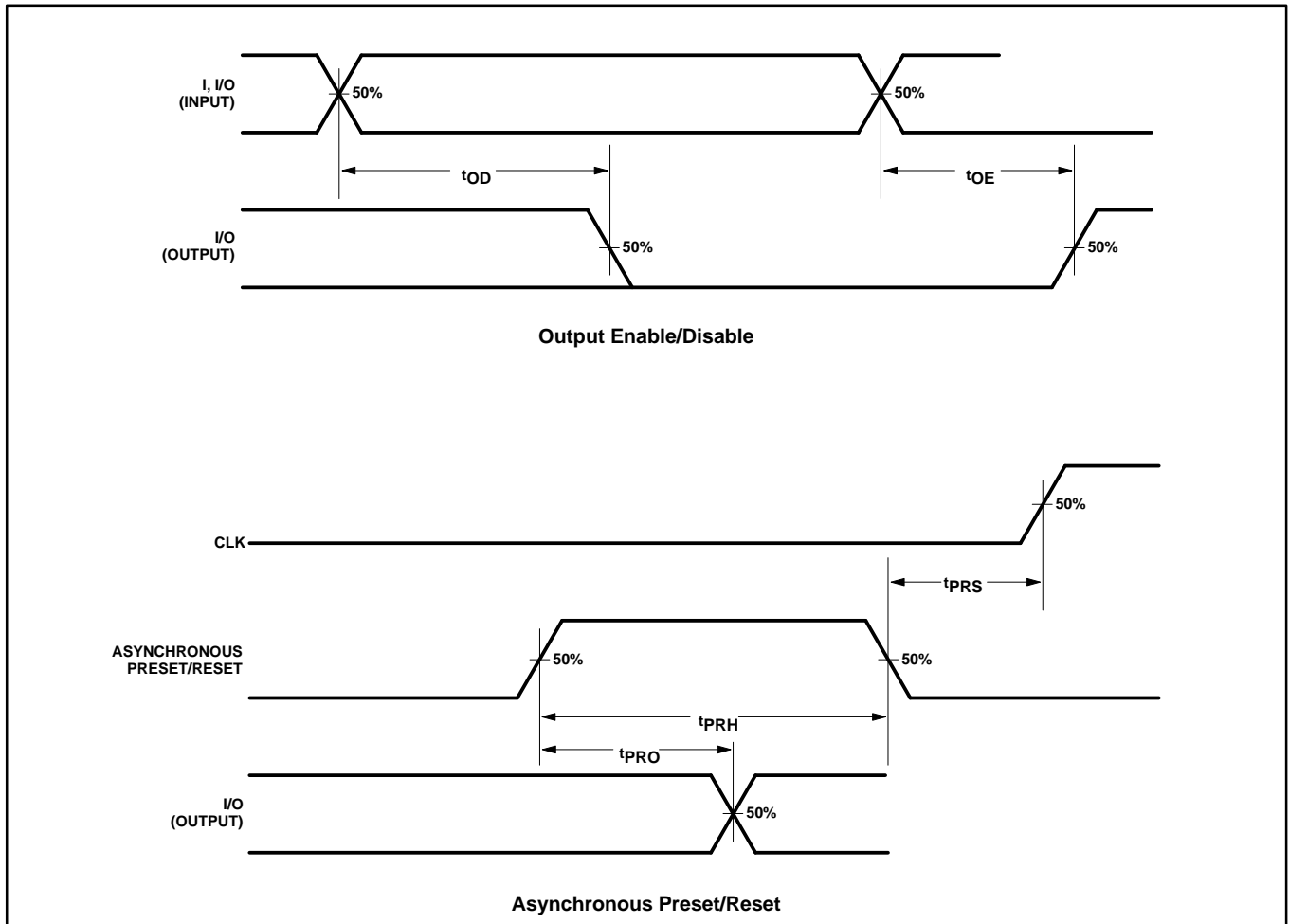


Power-On Reset

ECL programmable array logic

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TIMING DIAGRAMS (Continued)



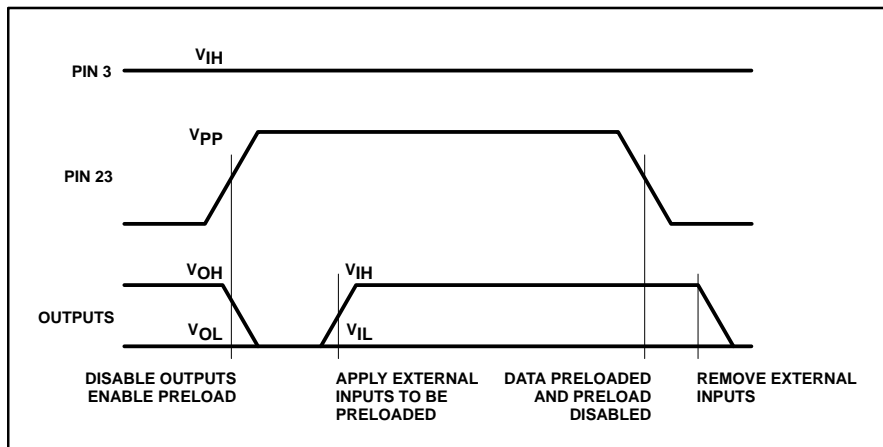
ECL programmable array logic

10H20EV8/10020EV8

REGISTER PRELOAD

The 10H20EV8/10020EV8 has included circuitry that allows a user to load data into the output registers. Register PRELOAD can be done at any time and is not dependent on any particular pattern programmed into the device. This simplifies the ability to fully verify logic states and sequences even after the device has been patterned.

The pin levels and sequence necessary to perform the register PRELOAD are shown below.



SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	TYP	MAX	
V_{IH}	Input HIGH level during PRELOAD and Verify	-1.1	-0.9	-0.7	V
V_{IL}	Input LOW level during PRELOAD and Verify	-1.85	-1.65	-1.45	V
V_{PP}	PRELOAD enable voltage applied to I_{11}	1.45	1.6	1.75	V

NOTE:

1. Unused inputs should be handled as follows:
 - Set at V_{IH} or V_{IL}
 - Terminated to $-2V$
 - Tied to V_{EE} through a resistor > 10K
 - Open

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LOGIC PROGRAMMING

The 10H20EV8/10020EV8 is fully supported by industry standard (JEDEC compatible) PLD CAD tools, including Philips Semiconductors SNAP design software package. ABEL™ and CUPL™ design software packages also support the 10H20EV8/10020EV8.

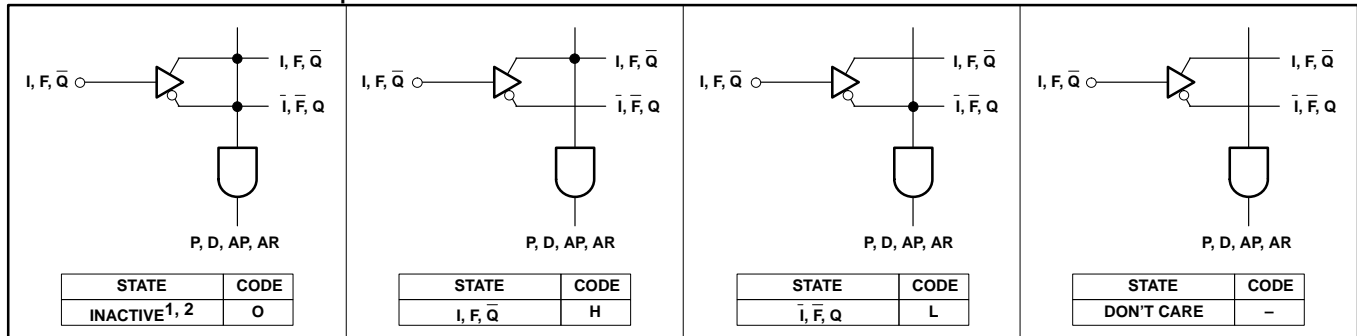
All packages allow Boolean and state equation entry formats. SNAP, ABEL and CUPL also accept, as input, schematic capture format.

10H20EV8/10020EV8 logic designs can also be generated using the program table entry format detailed on the following page. This

program table entry format is supported by SNAP only.

To implement the desired logic functions, the state of each logic variable from logic equations (I, F, Q, etc.) is assigned a symbol. The symbols for TRUE, COMPLEMENT, INACTIVE, PRESET, etc., are defined below.

“AND” ARRAY – (I), (F), (\bar{Q}_p)



NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (P, D, AP, AR) will be unconditionally inhibited if any one of the I, F or Q link pairs is left intact.

OUTPUT MACROCELL CONFIGURATIONS

OUTPUT MACROCELL CONFIGURATION	CONTROL WORD FUSE	POLARITY FUSE
Registered Output, Active-HIGH	D	H
Registered Output, Active-LOW	D ¹	L ¹
Combinatorial I/O, Active-HIGH	B	H
Combinatorial I/O, Active-LOW	B	L

NOTE:

1. This is the initial (unprogrammed) state of the device.

PROGRAMMING AND SOFTWARE SUPPORT

Refer to Section 9 (*Development Software*) and Section 10 (*Third-party Programmer/Software Support*) of the 1992 PLD Data Handbook for additional information.

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ECL programmable array logic

10H20EV8/10020EV8

SNAP

Features

- Schematic entry using DASH™ 4.0 or above or OrCAD™ SDT III
- State Equation Entry
- Boolean Equation Entry
- Allows design entry in any combination of above formats
- Simulator
 - Logic and fault simulation
 - Timing model generation for device timing simulation
 - Synthetic logic analyzer format
- Macro library for standard TTL and user defined functions
- Device independent netlist generation

- JEDEC fuse map generated from netlist

SNAP (Synthesis, Netlist, Analysis and Program) is a versatile development tool that speeds the design and testing of PML. SNAP combines a user-friendly environment and powerful modules that make designing with PML simple. The SNAP environment gives the user the freedom to design independent of the device architecture.

The flexibility in the variations of design entry methodologies allows design entry in the most appropriate terms. SNAP merges the inputs, regardless of the type, into a high-level netlist for simulation or compilation into a JEDEC fuse map. The JEDEC fuse map can then be transferred from the host computer to the device programmer.

SNAP's simulator uses a synthetic logic analyzer format to display and set the nodes of the design. The SNAP simulator provides complete timing information, setup and hold-time checking, plus toggle and fault grading analysis.

SNAP operates on an IBM® PC/XT, PC/AT, PS/2, or any compatible system with DOS 2.1 or higher. A minimum of 640K bytes of RAM is required together with a hard disk.

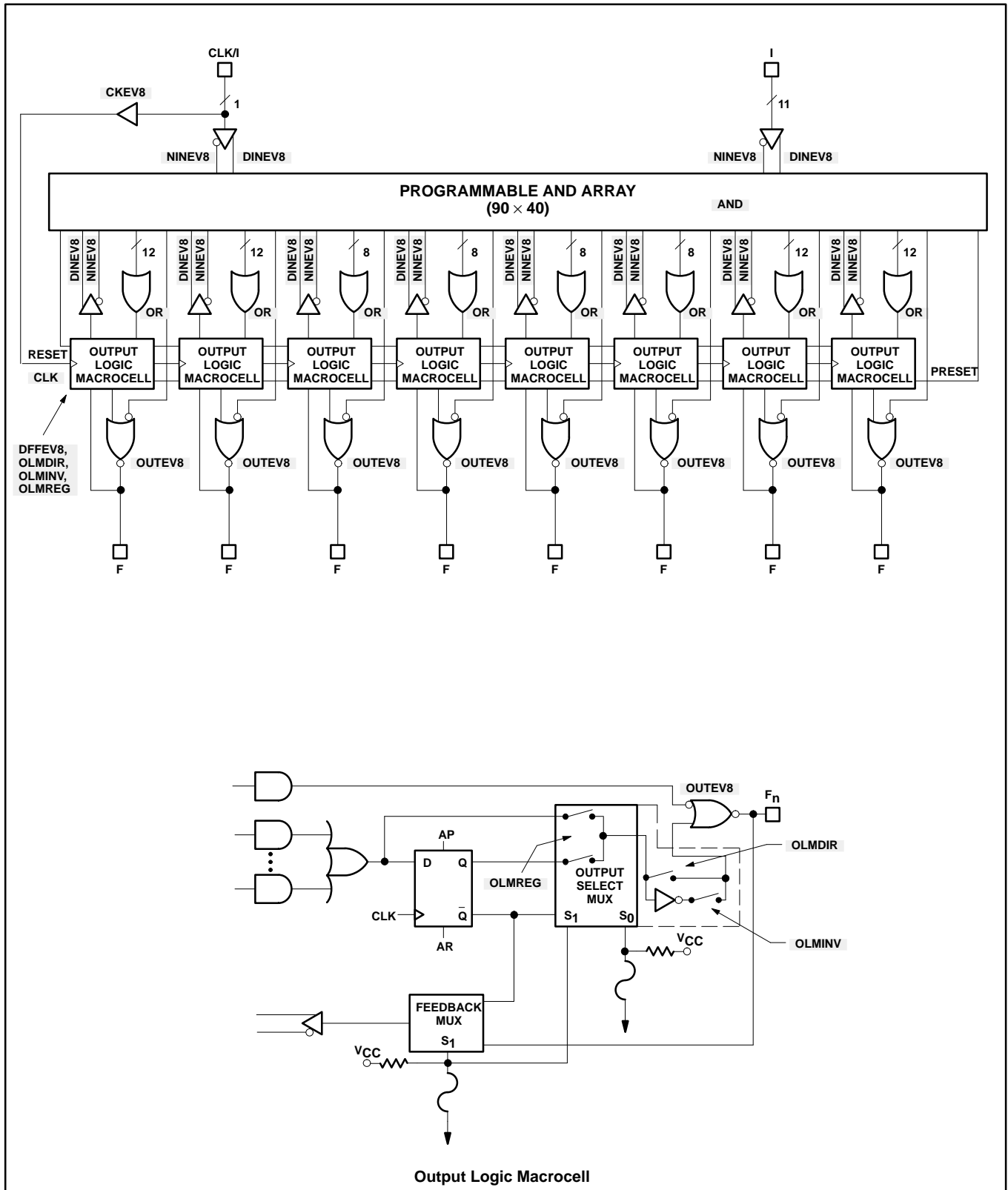
DESIGN SECURITY

The 10H20EV8/10020EV8 has a programmable security fuse that controls the access to the data programmed in the device. By using this programmable feature, proprietary designs implemented in the device cannot be copied or retrieved.

ECL programmable array logic

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SNAP RESOURCE SUMMARY DESIGNATIONS





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